

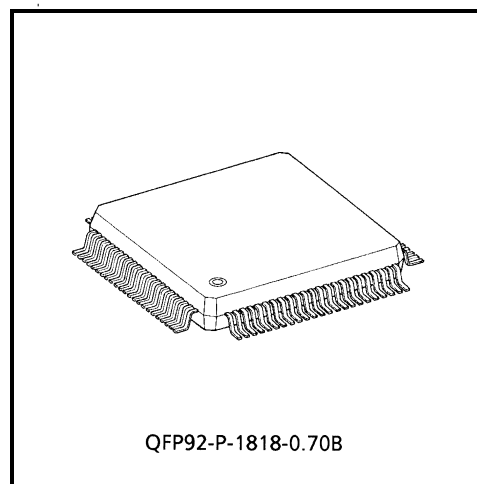
# T6B08

## ROW DRIVER FOR A DOT MATRIX LCD

The T6B08 is a 68-channel-output row driver for an STN dot matrix LCD. The T6B08 features a  $-28\text{V}$  LCD drive voltage. The T6B08 is able to drive LCD panels with a duty ratio of up to  $1/240$ . It is recommended for use with the T6B07.

### Features

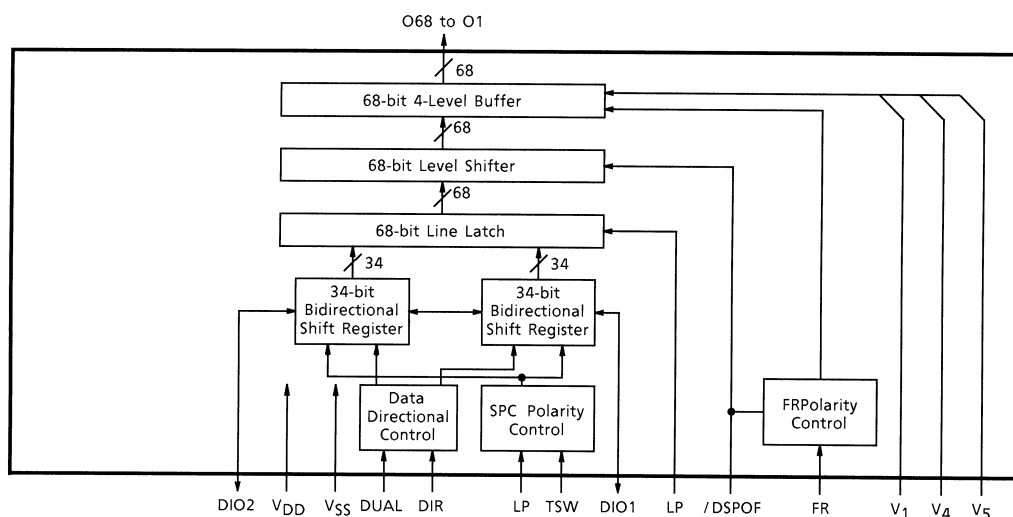
- Display duty application : to  $1/240$
- LCD drive signal : 68
- Data transfer : 1-bit bidirectional
  - (1)  $O68 \leftarrow O1$
  - (2)  $O68 \rightarrow O1$
  - (3)  $O1 \rightarrow O34$ ,  $O68 \rightarrow O35$
- LCD drive voltage :  $-11$  to  $-28\text{ V}$  (max  $-30\text{ V}$ )
- Operating voltage :  $3.0$  to  $5.5\text{ V}$
- Operating temperature :  $-20$  to  $75^\circ\text{C}$
- LCD drive output resistance :  $1.2\text{ k}\Omega$  (max) ( $12.8\text{ V}$ ,  $1/9$  bias)
- Display-off function : When/
- DSPOF is L, all LCD drive outputs ( $O1$  to  $O68$ ) remain at the  $V_{DD}$  level.
- LCD drive output timing : Change on falling edge of LP



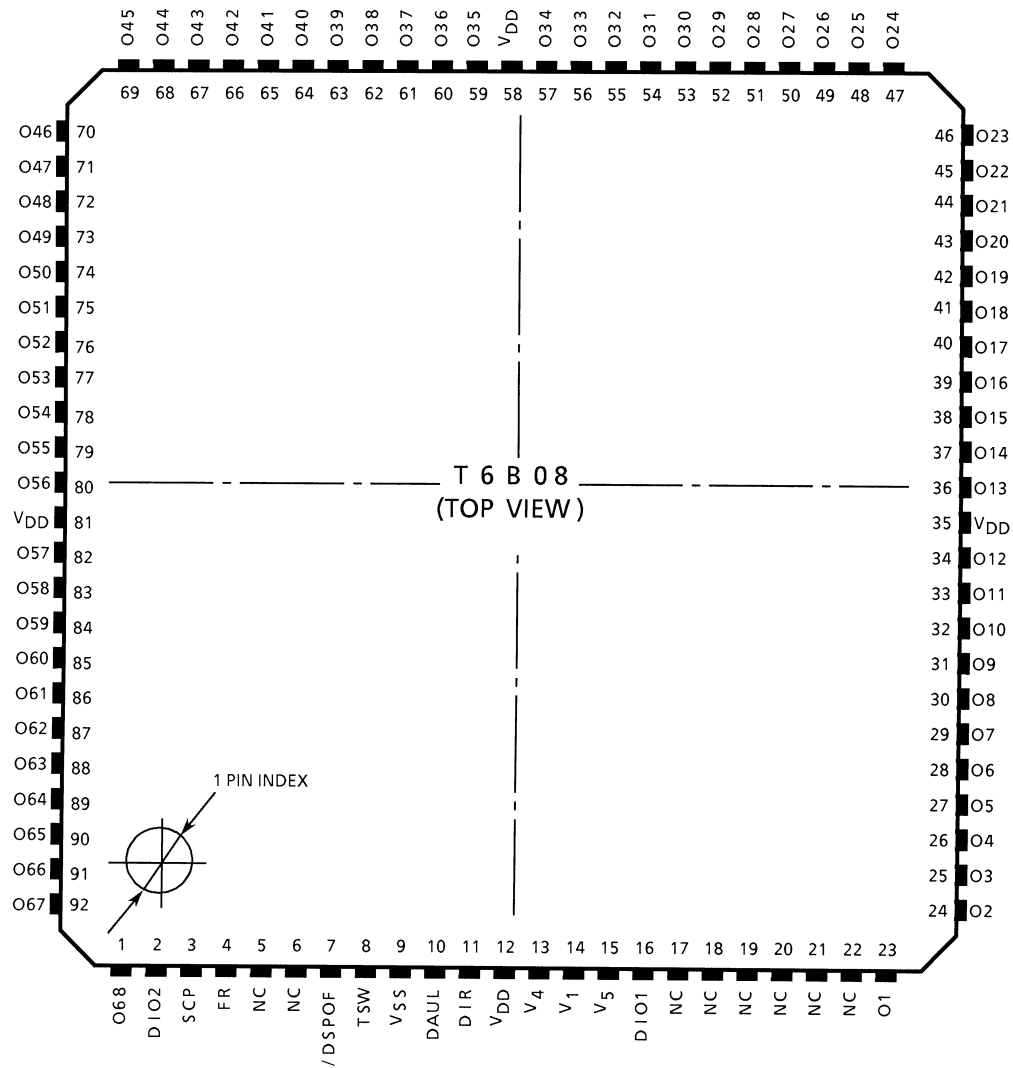
QFP92-P-1818-0.70B

Weight:  $1.45\text{ g}$  (typ.)

### Block Diagram



Pin Assignment



## Pin Functions

Pin Name	I / O	Functions	Level
O1 to O68	Output	Output for LCD drive signal	$V_{DD}$ to $V_5$
DIO1, DIO2	I / O	Input / output for shift data	$V_{DD}$ to $V_{SS}$
LP	Input	(Shift Clock Pulse) Input for shift clock pulse	
FR	Input	(Frame) Input for frame signal	
DUAL	Input	(Dual Mode) Terminal for dual input mode or single input mode select	
DIR	Input	(Direction) Input for data flow direction select	
TSW	Input	(Terminal Switch) When tied to $V_{SS}$ : (O1 to O68) output on the rising edge of LP When tied to $V_{DD}$ : (O1 to O68) output on the falling edge of LP	
/ DSPOF	Input	(Display Off) / DSPOF = L : Display-off mode, (O1 to O68) remain at the $V_{DD}$ level. / DSPOF = H : Display-on mode, (O1 to O68) are operational.	
$V_{DD}$	—	Power supply for internal logic (5 V)	—
$V_{SS}$	—	Power supply for internal logic (0 V)	
$V_1$	—	Power supply for LCD drive circuit	
$V_4$	—	Power supply for LCD drive circuit	
$V_5$	—	Power supply for LCD drive circuit	

## Relation Between FR, Data Input and Output Level

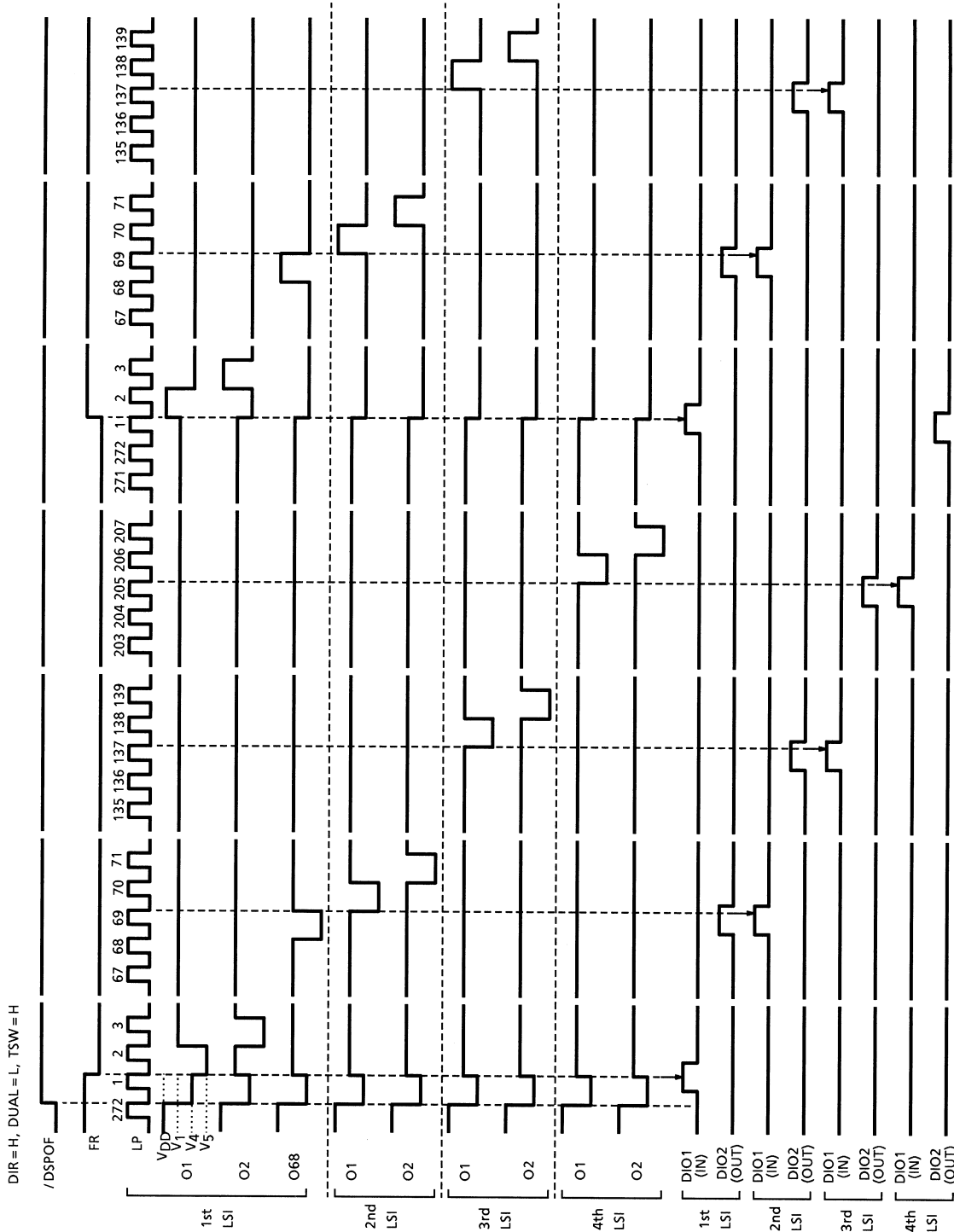
F R	Data Input (DIO1, DIO2)	/ DSPOF	Output Level
L	L	H	$V_1$
L	H	H	$V_5$
H	L	H	$V_4$
H	H	H	$V_{DD}$
*	*	L	$V_{DD}$

\*: Don't Care

## Data Input Format

DUAL	DIR	Data Flow	Data Input	
			DIO1	DIO2
$V_{DD}$	$V_{DD}$	O1 → O34	IN	IN
		O68 → O35		
$V_{SS}$	$V_{DD}$	O1 → O68	IN	OUT
$V_{DD}$	$V_{SS}$	O68 → O1	OUT	IN
$V_{SS}$	$V_{SS}$			

Timing Diagram



## Absolute Maximum Ratings

(Ensure that the Following Conditions are Maintained,  $V_{DD} \geq V_1 \geq V_4 \geq V_5$ ,  $V_{SS} = 0$ )

Item	Symbol	Pin Name	Rating	Unit
Supply Voltage 1	$V_{DD}$	$V_{DD}$	-0.3 to 7.0	V
Supply Voltage 2	$V_1$ $V_4$ $V_5$	$V_1$ $V_4$ $V_5$	$V_{DD} - 30.0$ to $V_{DD} + 0.3$	V
Input Voltage	$V_{IN}$	(Note 1)	-0.3 to $V_{DD} + 0.3$	V
Operating Temperature	$T_{opr}$	—	-20 to 75	°C
Storage Temperature	$T_{stg}$	—	-55 to 125	°C

Note 1: LP, FR, / DSPOF, TSW, DUAL, DIR, DIO1, DIO2

## Electrical Characteristics

### DC Characteristics

Test Conditions (1) (Unless Otherwise Noted,  $V_{SS} = 0$  V,  $V_{DD} = 4.5$  to  $5.5$  V,  $V_5 = (V_{DD} - 28)$  to  $(V_{DD} - 11)$  V,  $T_a = -20$  to  $75^\circ\text{C}$ )

Item	Symbol	Test Circuit	Test Condition	Min	Typ.	Max	Unit	Pin Name
Supply Voltage 1	—	—	—	4.5	5.0	5.5	V	$V_{DD}$
Supply Voltage 2	—	—	—	$V_{DD} - 28$	—	$V_{DD} - 11$	V	$V_5$
Input voltage	H Level	$V_{IH}$	—	$V_{DD} - 0.8$	—	$V_{DD}$	V	LP, FR, / DSPOF, TSW, DUAL, DIR, DIO1, DIO2
	L Level	$V_{IL}$	—	0	—	0.8		
Output voltage	H Level	$V_{OH}$	$I_{OH} = -0.5$ mA	$V_{DD} - 0.5$	—	$V_{DD}$	V	DIO1, DIO2
	L Level	$V_{OL}$	$I_{OL} = 0.5$ mA	0	—	0.5		
Output Resistance	H Level	$R_{OH}$	$V_{OUT} = V_{DD} - 0.5$ V (Note 2)	—	0.65	1.2	K $\Omega$	O1 to O68
	M Level	$R_{OM}$	$V_{OUT} = V_1 \pm 0.5$ V (Note 2)	—	0.65	1.2		
		$R_{OM}$	$V_{OUT} = V_4 \pm 0.5$ V (Note 2)	—	0.65	1.2		
	L Level	$R_{OL}$	$V_{OUT} = V_5 + 0.5$ V (Note 2)	—	0.65	1.2		
Current Consumption	$I_{SS}$	—	$V_{DD} = 5.5$ V $V_5 = -22.5$ V $f_{FR} = 35.5$ Hz $f_{LP} = 7.1$ kHz $f_{DIO} = 71$ Hz $V_{IH} = 5.5$ V, $V_{IL} = 0$ V	—	2.0	4.0	$\mu\text{A}$	$V_{SS}$

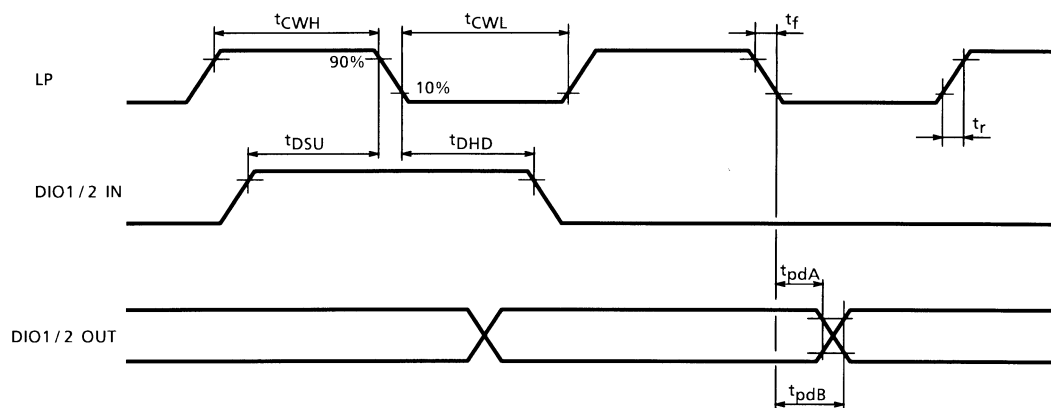
Note 2:  $V_{DD} = 5.0$  V,  $V_5 = -7.8$  V,  $V_1 = V_{DD} - 1/9 (V_{DD} - V_5)$ ,  $V_4 = V_{DD} - 8/9 (V_{DD} - V_5)$

Test Conditions (2) ( Unless Otherwise Noted,  $V_{SS} = 0\text{ V}$ ,  $V_{DD} = 3.0\text{ to }5.5\text{ V}$ ,  
 $V_5 = (V_{DD} - 28)\text{ to } (V_{DD} - 11)\text{ V}$ ,  
 $T_a = -20\text{ to }75^\circ\text{C}$  )

Item		Symbol	Test Cir- cuit	Test Condition	Min	Typ.	Max	Unit	Pin Name
Supply Voltage 1		—	—	—	3.0	3.3	5.5	V	$V_{DD}$
Supply Voltage 2		—	—	—	$V_{DD} - 28$	—	$V_{DD} - 11$	V	$V_5$
Input voltage	H Level	$V_{IH}$	—	—	$V_{DD} - 0.6$	—	$V_{DD}$	V	LP, FR, / DSPOF, TSW, DUAL, DIR, DIO1, DIO2
	L Level	$V_{IL}$		—	0	—	0.6		
Output voltage	H Level	$V_{OH}$	—	$I_{OH} = -0.5\text{ mA}$	$V_{DD} - 0.5$	—	$V_{DD}$	V	DIO1, DIO2
	L Level	$V_{OL}$		$I_{OL} = 0.5\text{ mA}$	0	—	0.5		
Output Resistance	H Level	$R_{OH}$	—	$V_{OUT} = V_{DD} - 0.5\text{ V}$ (Note 3)	—	0.65	1.2	k $\Omega$	O1 to O68
	M Level	$R_{OM}$		$V_{OUT} = V_1 \pm 0.5\text{ V}$ (Note 3)	—	0.65	1.2		
		$R_{OM}$		$V_{OUT} = V_4 \pm 0.5\text{ V}$ (Note 3)	—	0.65	1.2		
	L Level	$R_{OL}$		$V_{OUT} = V_5 + 0.5\text{ V}$ (Note 3)	—	0.65	1.2		
Current Consumption		$I_{SS}$	—	$V_{DD} = 5.5\text{ V}$ $V_5 = -22.5\text{ V}$ $f_{FR} = 35.5\text{ Hz}$ $f_{LP} = 7.1\text{ kHz}$ $f_{DIO} = 71\text{ Hz}$ $V_{IH} = 5.5\text{ V}$ , $V_{IL} = 0\text{ V}$	—	2.0	4.0	$\mu\text{A}$	$V_{SS}$

Note 3:  $V_{DD} = 3.0\text{ V}$ ,  $V_5 = -9.8\text{ V}$ ,  $V_1 = V_{DD} - 1 / 9 (V_{DD} - V_5)$ ,  $V_4 = V_{DD} - 8 / 9 (V_{DD} - V_5)$

## AC Characteristics



## Test Conditions (1)

( $V_{SS} = 0\text{ V}$ ,  $V_{DD} = 4.5\text{ to }5.5\text{ V}$ ,  $V_5 = (V_{DD} - 28)\text{ to } (V_{DD} - 11)\text{ V}$ ,  $T_a = -20\text{ to }75^\circ\text{C}$ )

Item	Symbol	Test Condition	Min	Max	Unit
SCP Pulse Width H	$t_{CWH}$	LP	40	—	ns
SCP Pulse Width L	$t_{CWL}$	LP	1	—	$\mu\text{s}$
Input Rise / Fall Time	$t_r, t_f$	LP, FR, DIO1, DIO2	—	(Note 6)	ns
Data Set-up Time	$t_{DSU}$	DIO1, DIO2	40	—	ns
Data Hold Time	$t_{DHD}$	DIO1, DIO2	40	—	ns
Output Data Delay Time A (Note 5)	$t_{pdA}$	DIO1, DIO2	500	—	ns
Output Data Delay Time B (Note 5)	$t_{pdB}$	DIO1, DIO2	—	1	$\mu\text{s}$

## Test Conditions (2)

( $V_{SS} = 0\text{ V}$ ,  $V_{DD} = 3.0\text{ to }5.5\text{ V}$ ,  $V_5 = (V_{DD} - 28)\text{ to } (V_{DD} - 11)\text{ V}$ ,  $T_a = -20\text{ to }75^\circ\text{C}$ )

Item	Symbol	Test Condition	Min	Max	Unit
SCP Pulse Width H	$t_{CWH}$	LP	50	—	ns
SCP Pulse Width L	$t_{CWL}$	LP	1	—	$\mu\text{s}$
Input Rise / Fall Time	$t_r, t_f$	LP, FR, DIO1, DIO2	—	(Note 6)	ns
Data Set-up Time	$t_{DSU}$	DIO1, DIO2	50	—	ns
Data Hold Time	$t_{DHD}$	DIO1, DIO2	50	—	ns
Output Data Delay Time A (Note 5)	$t_{pdA}$	DIO1, DIO2	700	—	ns
Output Data Delay Time B (Note 5)	$t_{pdB}$	DIO1, DIO2	—	1	$\mu\text{s}$

Note 5:  $C_L = 10\text{ pF}$

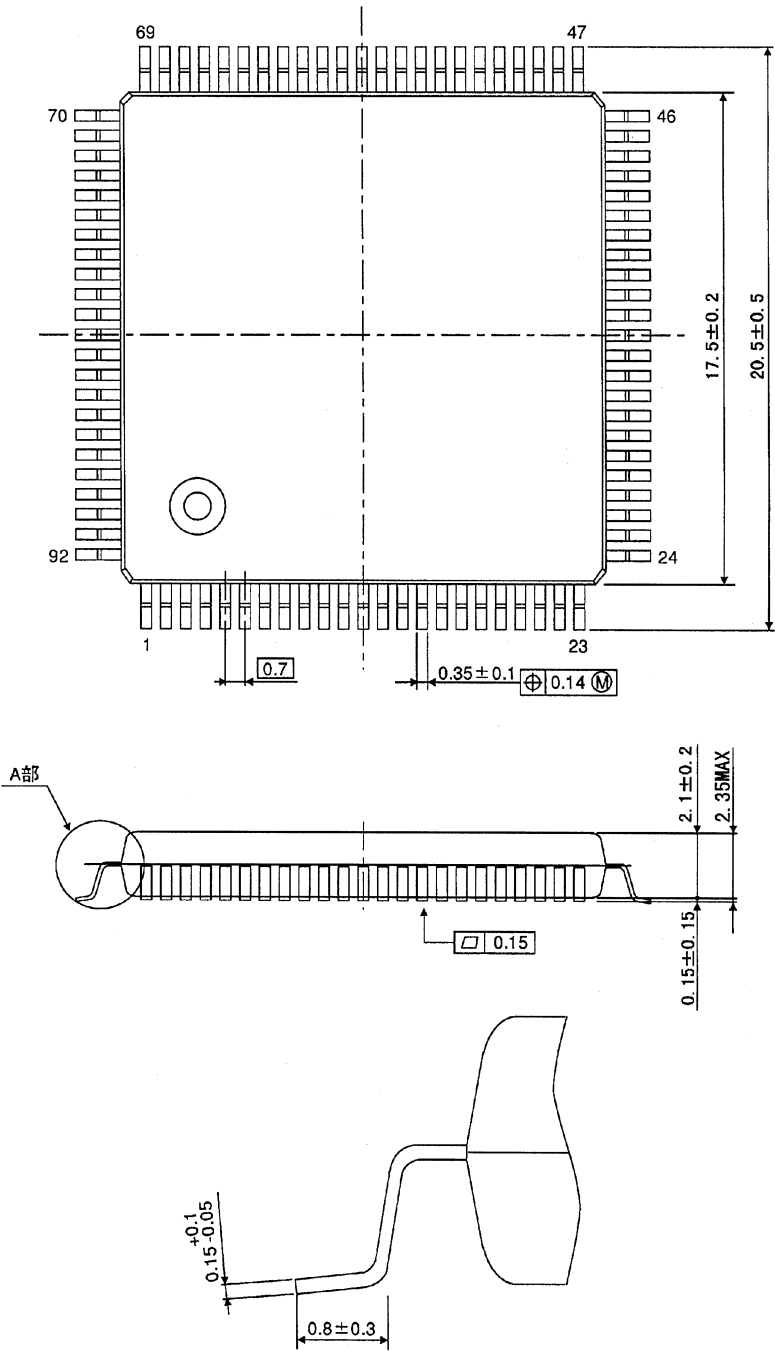
Note 6:  $t_r, t_f \leq (t_C - t_{CWH} - t_{CWL}) / 2$  or  $t_r, t_f \leq 50\text{ ns}$

Note: Insert the bypass capacitor ( $0.1\text{ }\mu\text{F}$ ) between  $V_{DD}$  and  $V_{SS}$  to decrease the power supply noise.  
Place the bypass capacitor as close to the LSI as possible.

Package Dimensions

QFP92-P-1818-0.70B

Unit : mm



Weight : 1.45 g (Typ.)



**RESTRICTIONS ON PRODUCT USE**

000707EBA

- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property.  
In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc..
- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.). These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc.. Unintended Usage of TOSHIBA products listed in this document shall be made at the customer's own risk.
- The products described in this document are subject to the foreign exchange and foreign trade laws.
- The information contained herein is presented only as a guide for the applications of our products. No responsibility is assumed by TOSHIBA CORPORATION for any infringements of intellectual property or other rights of the third parties which may result from its use. No license is granted by implication or otherwise under any intellectual property or other rights of TOSHIBA CORPORATION or others.
- The information contained herein is subject to change without notice.